

**Search Notes**

Application/Control No.

10/643,531

Examiner

Adolf Berhane

Applicant(s)/Patent under  
Reexamination

CHIAN ET AL.

Art Unit

2838

**SEARCHED**

Class	Subclass	Date	Examiner
363	18		
	19		
	20		
	21.01		
	49		
131	6/12/2006	AB	

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner